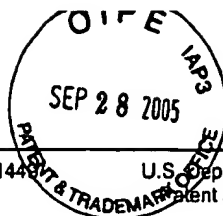




Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. <b>12732-063001</b>	Application No. <b>09/919,832</b>
	Applicant <b>Shunpei Yamazaki et al.</b>		
	Filing Date <b>August 2, 2001</b>	Group Art Unit <b>2674</b>	

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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	



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	Applicant Shunpei Yamazaki et al.			
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